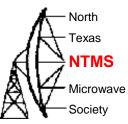


LDO noise effects – part 1

July 1, 2023

KM5PO & KI5EMN

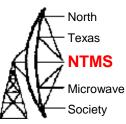
"Noise" is everywhere



- Noise is an unwanted disturbance in an electrical signal
- Noise generated by electronic devices varies greatly as it is produced by several different effects.
- In particular, noise is inherent in physics and central to <u>thermodynamics</u>. Any conductor with <u>electrical resistance</u> will generate thermal noise inherently. The final elimination of thermal noise in electronics can only be achieved <u>cryogenically</u>, and even then <u>quantum noise</u> would remain inherent.

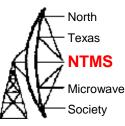
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"Noise" types



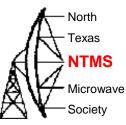
- **Thermal** generated by the random thermal motion of charge carriers (usually <u>electrons</u>), inside an <u>electrical</u> <u>conductor</u>, which happens regardless of any applied <u>voltage</u>
- Shot random statistical fluctuations of the <u>electric current</u> when the charge carriers (such as electrons) traverse a gap. If electrons flow across a barrier, then they have discrete arrival times
- Partition where current divides between two (or more) paths
- Flicker a signal or process with a frequency spectrum that falls off steadily into the higher frequencies
- **Burst** sudden step-like transitions between two or more discrete voltage or current levels
- **Transit-time** If the time taken by the electrons to travel from emitter to collector in a transistor becomes comparable to the period of the signal being amplified
- Coupled
 - can be coupled into a circuit from the external environment, by <u>inductive coupling</u> or <u>capacitive coupling</u>, or through an antenna..
 - Intermod/Crosstalk/Interference/Atmospheric/Industrial/Solar

Mitigation



- Faraday cage A <u>Faraday cage</u> enclosing a circuit can be used to isolate the circuit from external noise sources. A Faraday cage cannot address noise sources that originate in the circuit itself or those carried in on its inputs, including the power supply.
- Capacitive coupling <u>Capacitive coupling</u> allows an AC signal from one part of the circuit to be picked up in another part *through the interaction of electric fields.* Where coupling is unintended, the effects can be addressed through improved circuit layout and grounding.
- 3. Ground loops When grounding a circuit, it is important to avoid <u>ground</u> <u>loops</u>. Ground loops occur when there is a voltage difference between two ground connections. A good way to fix this is to bring all the ground wires to the same potential in a ground bus.

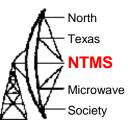
Mitigation



- Shielding cables A <u>shielded cable</u> can be thought of as a Faraday cage for wiring and can protect the wires from unwanted noise in a sensitive circuit. The shield must be grounded to be effective. Grounding the shield at only one end can avoid a ground loop on the shield.
- Twisted pair wiring <u>Twisting wires</u> in a circuit will reduce electromagnetic noise. Twisting the wires decreases the loop size in which a magnetic field can run through to produce a current between the wires. Small loops may exist between wires twisted together, but the magnetic field going through these loops induces a current flowing in opposite directions in alternate loops on each wire and so there is no net noise current.
- Notch filters Notch filters or <u>band-rejection filters</u> are useful for eliminating a specific noise frequency. For example, power lines within a building run at 50 or 60 Hz <u>line frequency</u>. A sensitive circuit will pick up this frequency as noise. A notch filter tuned to the line frequency can remove the noise.

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LDO PSRR vs other noise



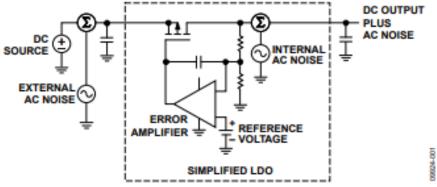
Power Supply Rejection Ratio (PSRR)

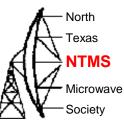
Is a measure of circuit's power supply rejection expressed as a ratio of output noise to noise at the power supply input – is a function of frequency/affected by the gain bandwidth of the EA/load current variation has impacts

PSRR = 20 log (Ripple input divided by Ripple output)

Other LDO noise

Noise generated by the transistors and resistors in the LDO's internal circuitry (thermal, flicker, shot) and by the external components





Mats referred me to the Sparkos LDO



__ SparkoS___

SPARKOSLABS.COM

Description :

The SS78XX / SS1117XX / SS79XX family of discrete voltage regulators are available in a TO-220 compatible package and are made to drop-in replace inferior monolithic voltage regulators. They are available in a wide output voltage range from +/- 3.3 to +/- 24 volts with over 1 amp of available output current.

Features:

• - 125dB input rejection

- 3.2uV RMS Output Noise in a 20Khz
- Bandwidth @ 5 Vo
- 2mV Load Regulation
- Output Current Of 1 Amp With Proper Heat Sinking
- Over Current Protection
- Output Decoupling Capacitor On Board
- TO220 Compatible Package
- Stable With Ceramic And Low ESR
 Output Capacitors
- Available In Positive And Negative Fixed Outputs
- Available In 3 Different Industry Standard Pin-outs
- Fully Discrete Design Including The Error Amplifier

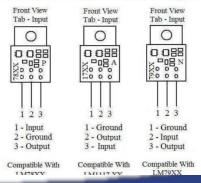
SS78XX / SS1117XX / SS79XX

Discrete Voltage Regulator Family



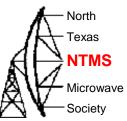
Pin Assignments

SS78XX Positive SS1117-XX Positive SS79XX Negative

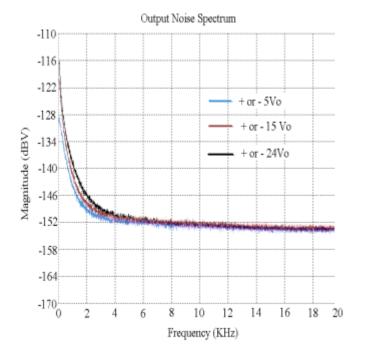


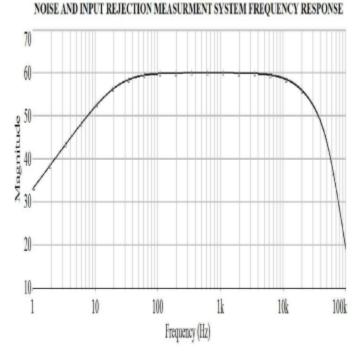
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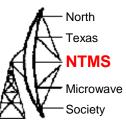


In the datasheet

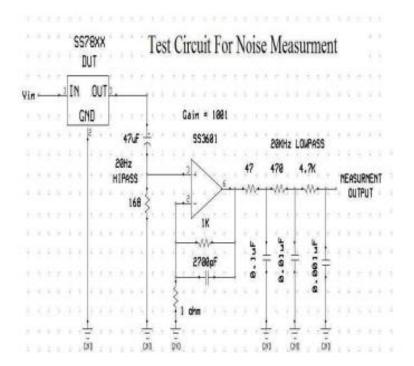




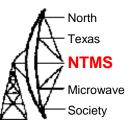
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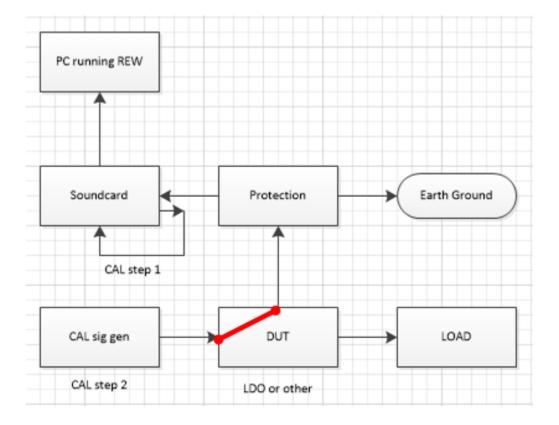
In the datasheet



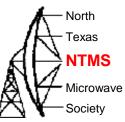
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Noise measuring setup



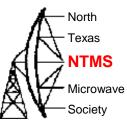
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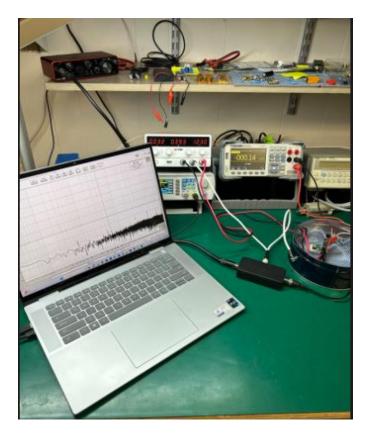
Protection for soundcard

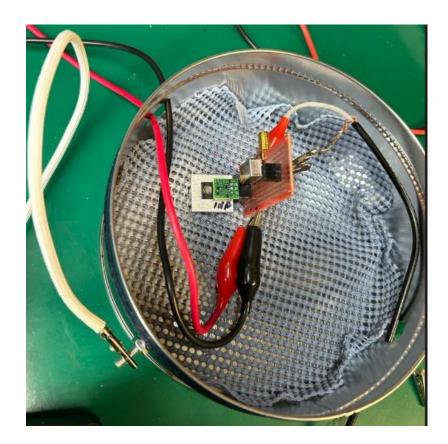


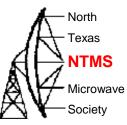




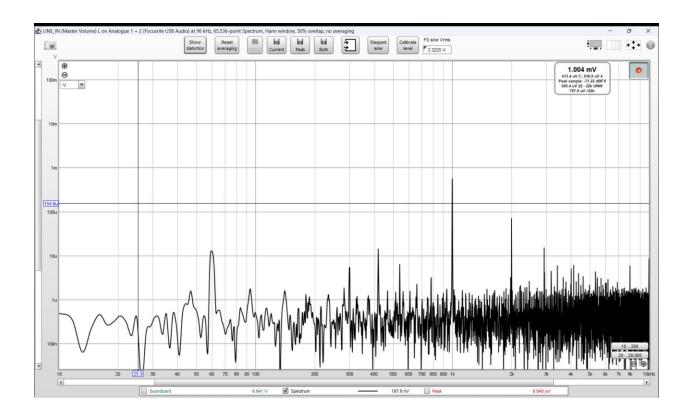
Ready to measure





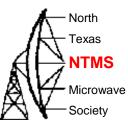


Calibrated system – laptop powered 6-10-23 Measurement of 1 Khz at .001v (1 mV) in the tin can

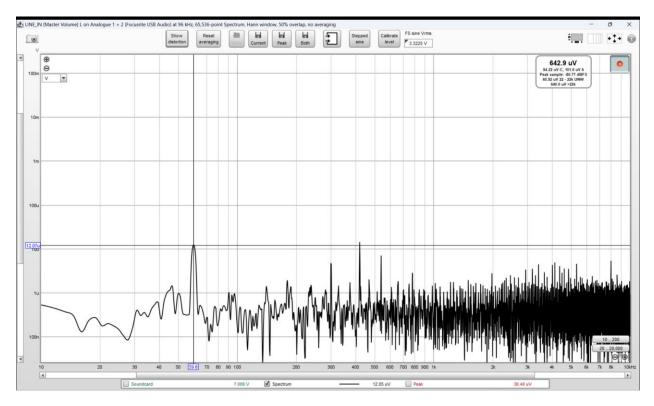


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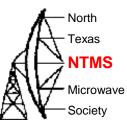
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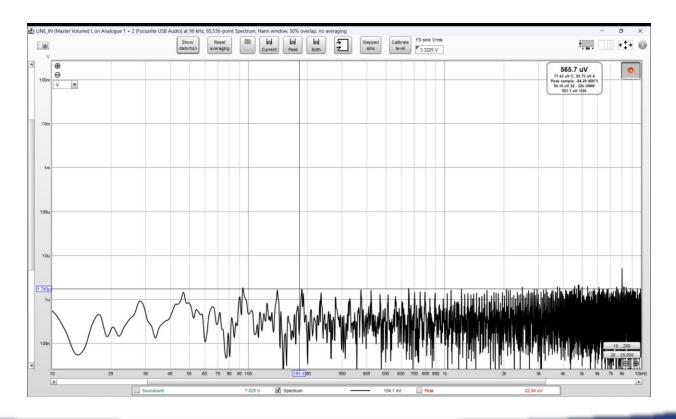
Calibrated system – laptop powered 6-10-23 Measurement of 51 ohm resistor in the tin can 12 uV of ripple at 60 hz

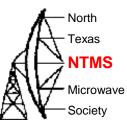


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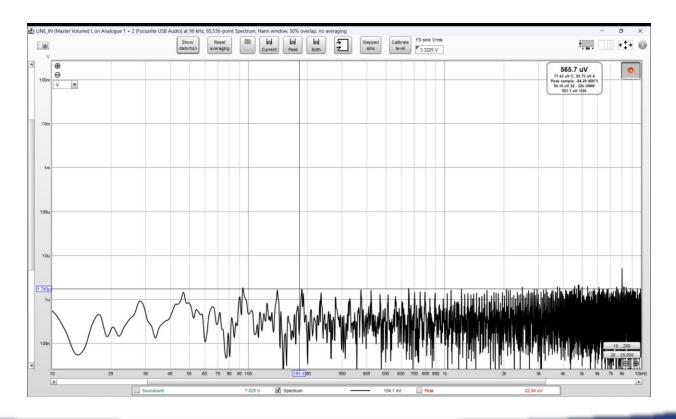


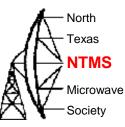
Calibrated system – laptop on battery 6-10-23 Measurement of 51 ohm resistor in the tin can Peak of 1.74 uV < 20 KHz ~280 nV average noise < 20 Khz





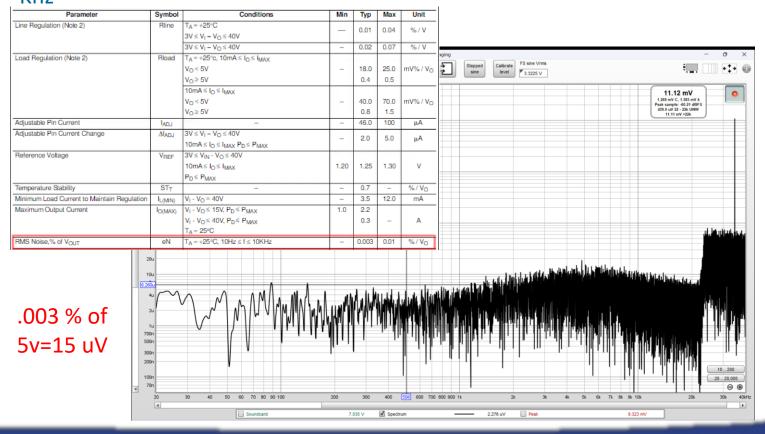
Calibrated system – laptop on battery 6-10-23 Measurement of 51 ohm resistor in the tin can Peak of 1.74 uV < 20 KHz ~280 nV average noise < 20 Khz

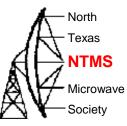




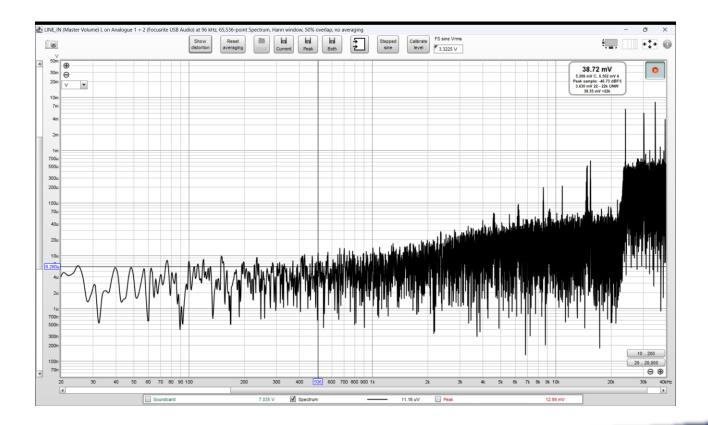
17

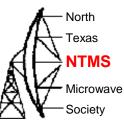
LM317 number 1 breadboarded circuit (12 vDC in -5 vDC out -51 ohm load -75 mA draw) ~ 5-7 uV peaks below 2 khz, broad peak of 15 uV on 5 KHz, 10 mV spike at 35 Khz



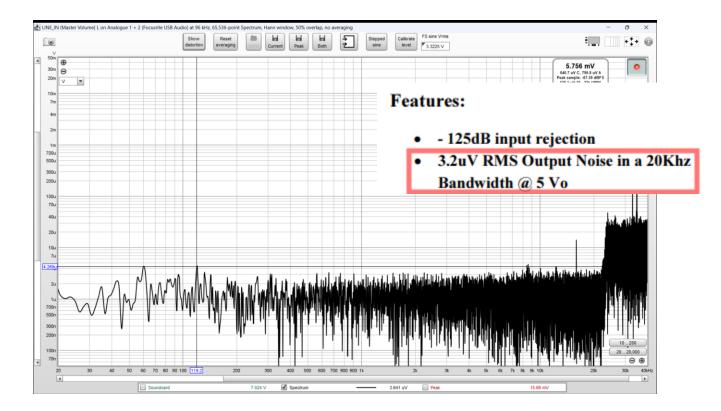


MH-MINI-360 (12 vDC in – 5 vDC out – 51 ohm load) ~6 to 10 uV peaks <500 Hz, rising noise of 10 to 40 uV at 20 KHz, peak of ~ 1 mV at 12 KHz

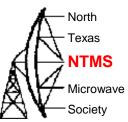




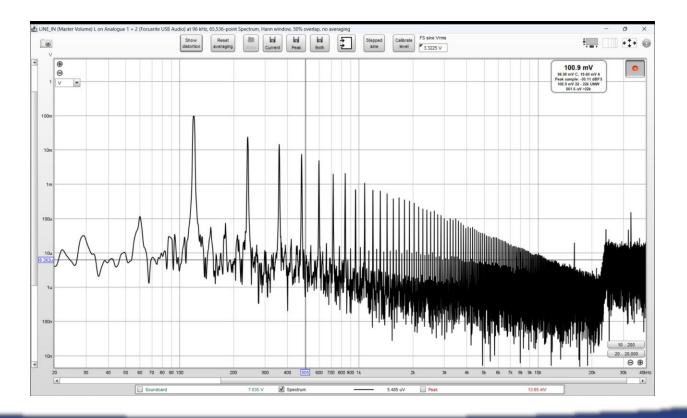
Sparkos lab SS7805 (12 vDC in – 5 vDC out – 51 ohm load - 120 mA draw) \sim 4 uV peak at 120 hz otherwise < 3 uV from 50 hz to 20 khz and 5 mV spike at 35 khz



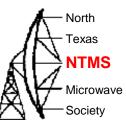
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DigiLO wal wart power supply 100 mV ripple at 120 hz

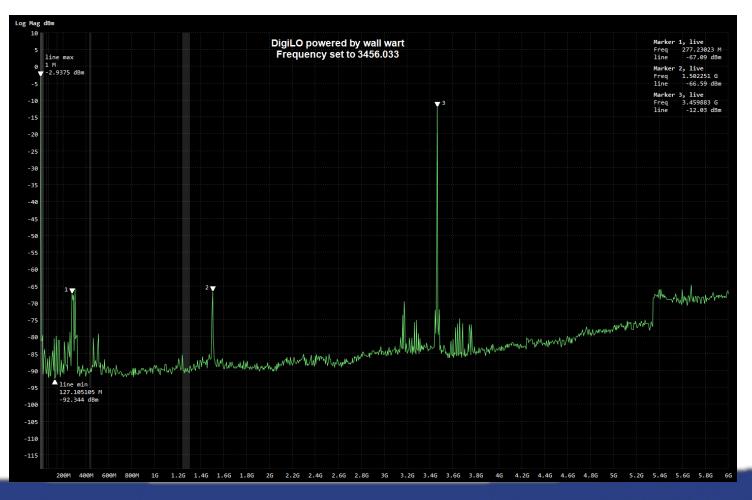


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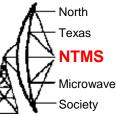


Spectrum effects

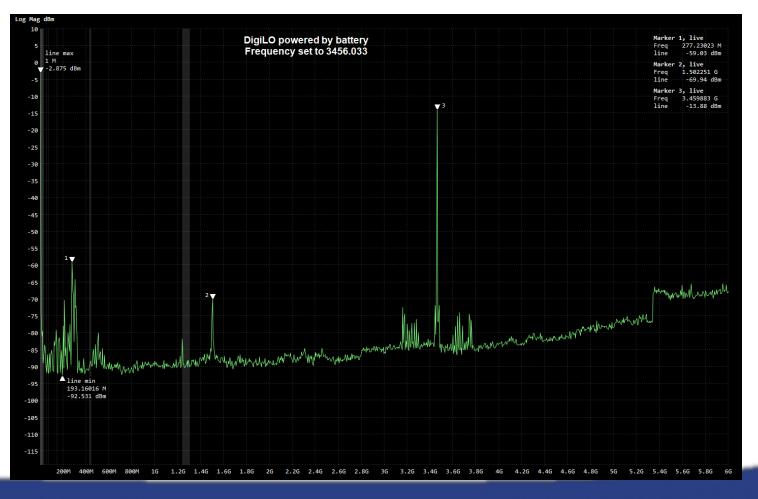
DigiLO output spectrum



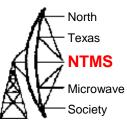




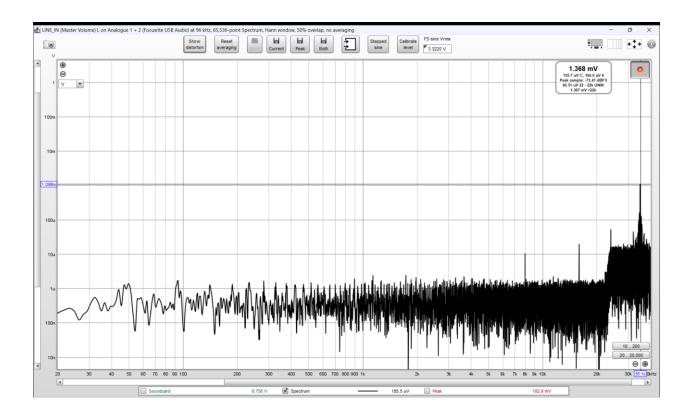
DigiLO output spectrum



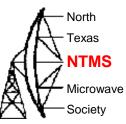
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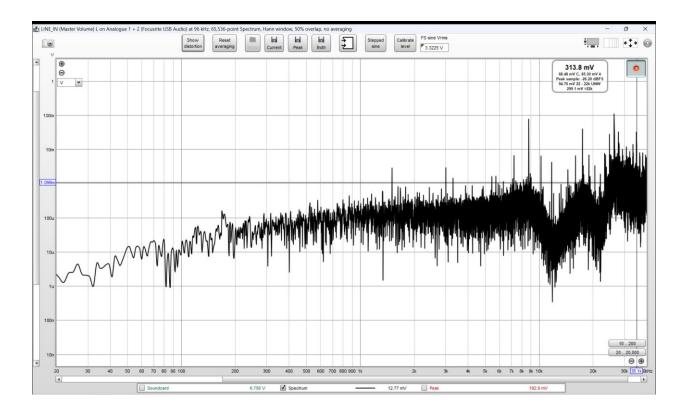
iPhone charger (120vAC in 5.0 vDC out) 1 mV spike at 35 KHz

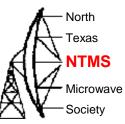


W5HN

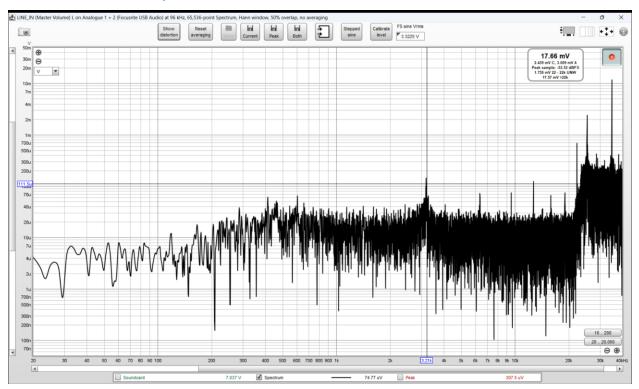


"Switcher power supply" (120vAC in 6.0 vDC out) I was using back in 2008 to drive a T/R relay for 1296 MHz



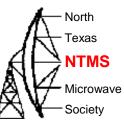


Buck converter XL4016E1 number 1 (12vDC in – 5.0vDC out – 100 ohm load – 50 mA draw) ~40 uV < 20 Khz, broad 100+ uV spike at 43.2 Khz, 11 mV spike at 35

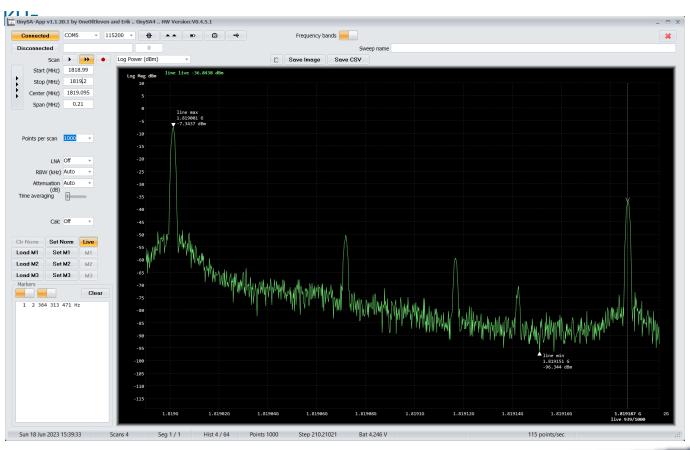


W5HN

Spectrum effects



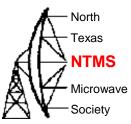
Wavelab 1819 MHz LO - McCoy 10 MHz OCXO (12 vDC) sharing PDU with 24 GHz system (uses XL4016 buck conv) – spur is -37 ~+184



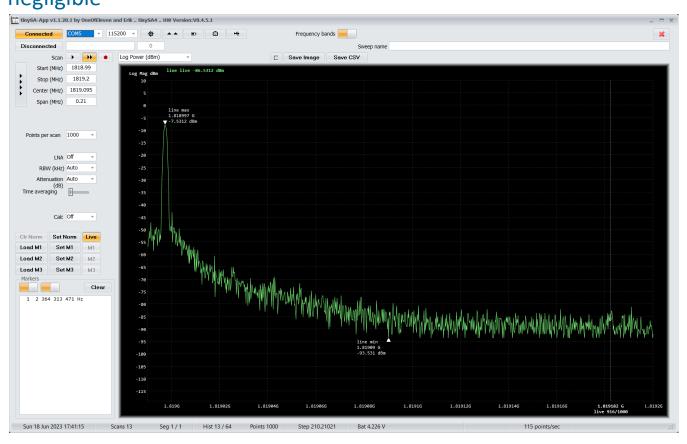
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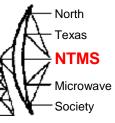
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Spectrum effects



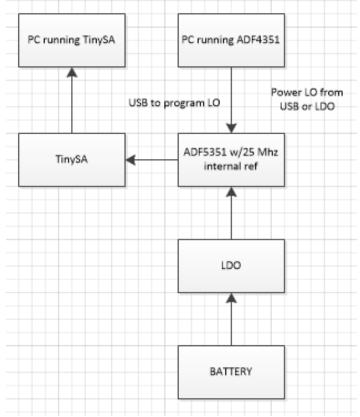
Wavelab 1819 MHz LO - 5v 10 MHz OCXO powered by Sparkos LDO sharing PDU with 24 GHz system (uses XL4016 buck conv) – spur is negligible

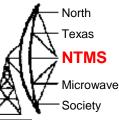




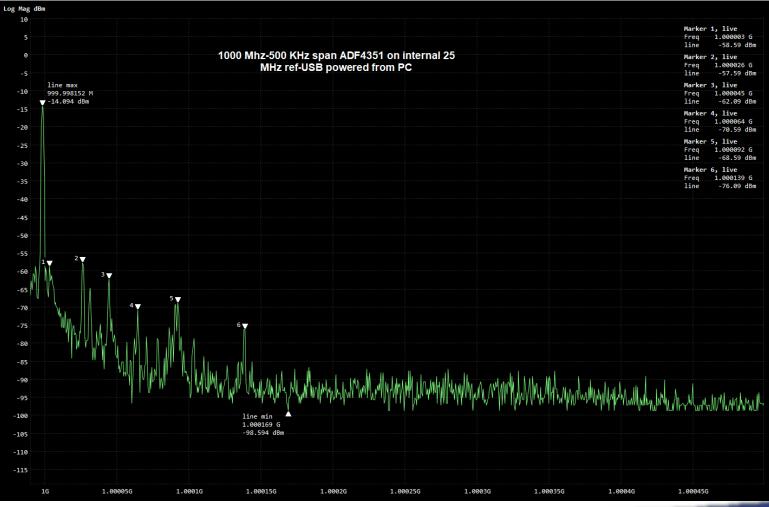
Focus testing



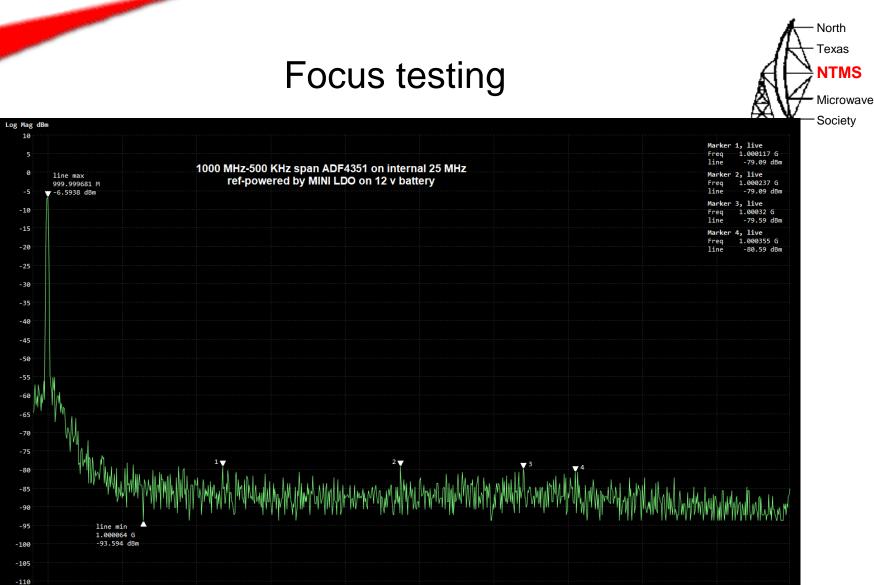




Focus testing



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1.00005G

1.00015G

1.0001G

1.00026

1.00025G

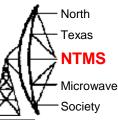
-115

1.0004G

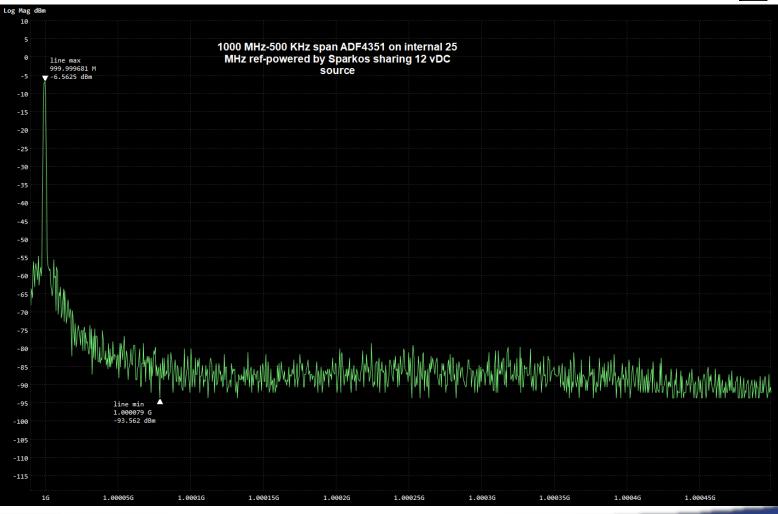
1.00045G

1.00035G

1.0003G

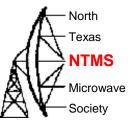


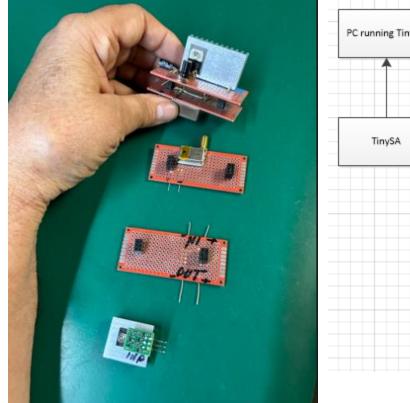
Focus testing

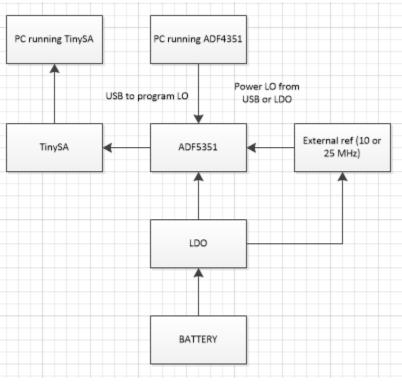


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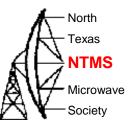
Focus testing



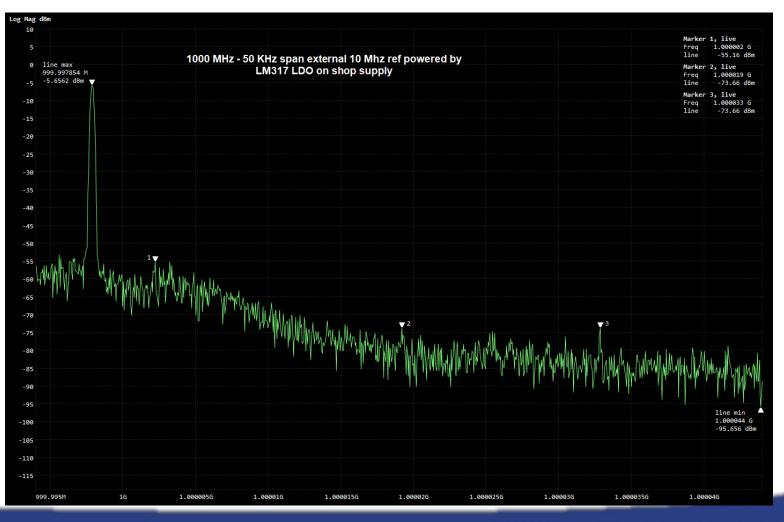




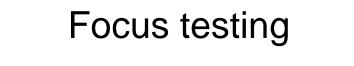
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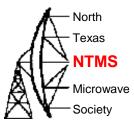


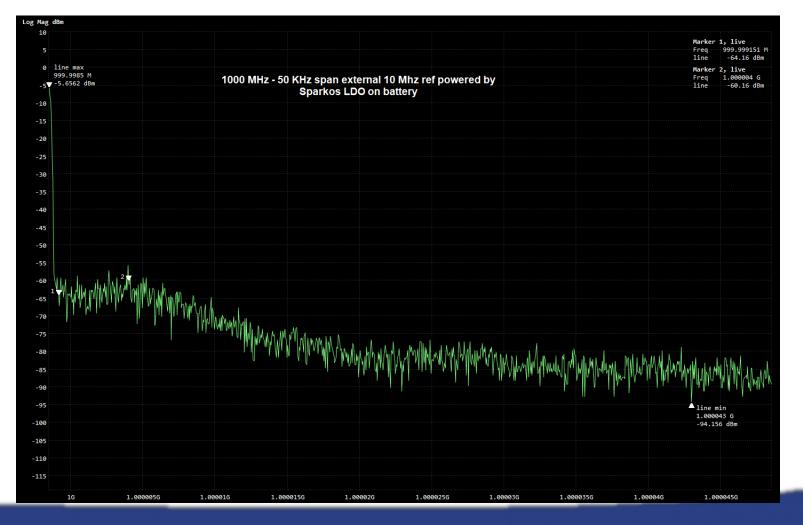
Focus testing – 50 KHz span



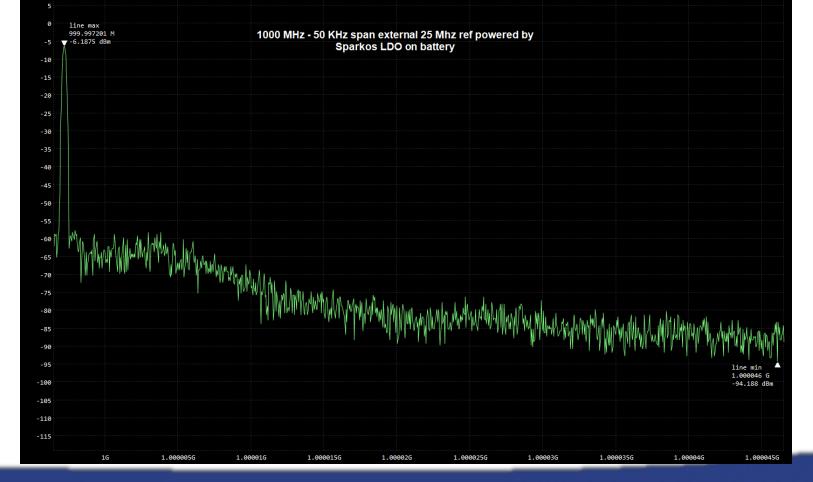
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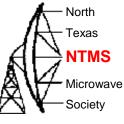


Log Mag dBm

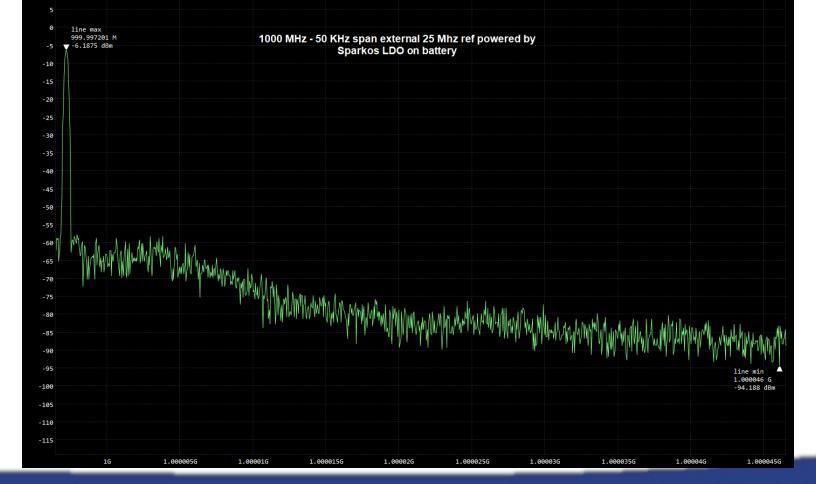


35

Focus testing

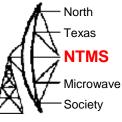


Log Mag dBm

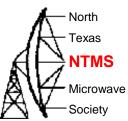


36

Focus testing



Next steps - to be continued

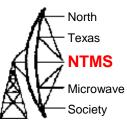


Spectral Noise density curve and a rising noise floor for RF apps

Effects on ADC or DAC. Sampling system causes high frequency noise to fold to lower frequencies due to aliasing

- Reducing LDO noise-
- Understanding the datasheet
- Use best LDO you can afford
- Cascade multiple LDOs

Questions?





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